## CLAIMS

## What is claimed is:

- 1 1. A packaging structure comprising at least one semiconductor device bonded to a
- 2 chip carrier or heat spreader with an adhesive, wherein the adhesive is reworkable and
- 3 thermally conductive and comprises a cured reaction product from a diepoxide and cyclic
- 4 anhydride wherein the epoxy groups are connected through an acyclic acetal moiety; and
- 5 a thermally conductive filler.
- 1 2. The packaging structure of claim 1 wherein the diepoxide is a cycloaliphatic
- 2 diepoxide.
- 1 3. The packaging structure of claim 1 wherein the diepoxide is selected from the
- 2 group consisting of acetaldehyde bis (3,4-epoxycyclohexylmethyl) acetal, acetone bis-
- 3 (3,4- epolycyclohexylmethyl) ketal, and formaldehyde bis- )4,4-epoxycyclohexylmethyl)
- 4 acetal.
- 1 4. The packaging structure of claim 1 where the diepoxide is acetaldehyde bis- (3,4-
- 2 epoxycyclohexylmethyl) acetal.
- The packaging structure of claim 1 wherein the filler is non-electrically
- 2 conductive.
- 1 6. The packaging structure of claim 1 wherein the filler is selected from the group
- 2 consisting of silver flake, aluminum nitride and silica-coated aluminum nitride.
- 1 7. The packaging structure of claim 1 wherein the filler is aluminum nitride or silica-
- 2 coated aluminum nitride.

- 1 8. The packaging structure of claim 1 where the adhesive further comprises a
  2 thixotropic agent.

  1 9. The packaging structure of claim 1 wherein the filler is electrically conductive.

  1 10. The packaging structure of claim 1 where the thixotropic agent comprises silica or
  2 siloxane-coated furned silica.
- 1 11. The packaging structure of claim 10 wherein (a) the amount of diepoxide is about
- 2 10 to about 30% by weight, (b) the amount of cyclic anhydride is about 10 to about 30%
- 3 by weight,(c) the amount of filler is about 40% to about 79% by weight and (d)
- 4 thixotropic agent about 0.05 to about 2% by weight, the amounts being based on the
- 5 total of (a), (b), (c) and (d) in the composition.
- 1 12. The packaging structure of claim 1 wherein the adhesive provides a void-free
- 2 bond.
- 1 13. The packaging structure of claim 1 wherein the at least one semiconductor device
- 2 is bonded to a chip carrier and is electrically connected to the chip carrier with
- 3 wirebonds.
- 1 14. The packaging structure of claim 1 wherein the at least one semiconductor device
- 2 is a flip chip and the flip chip is bonded to the heat spreader.
- 1 15. The packaging structure of claim 14 which further comprises an underfill
- 2 encapsulant.

- 1 16. A method for fabricating a packaging structure which comprises bonding at least
- 2 one semiconductor device to a chip carrier by applying a composition comprises a
- 3 diepoxide wherein the epoxy groups are connected through an acyclic acetal moiety, a
- 4 cyclic anhydride and a thermally conductive filler; and curing the composition to provide
- 5 a reworkable and thermally conductive adhesive.
- 1 17. The method of claim 16 wherein the diepoxide is a cycloaliphatic diepoxide.
- 1 18. The method of claim 16 wherein the diepoxide is selected from the group
- 2 consisting of acetaldehyde bis- (3,4-epoxycyclohexylmethyl) acetal, acetone bis- (3,4-
- 3 epoxycyclohexylmethyl) ketal, and formaldehyde bis- (3,4-epoxycyclohexylmethyl)
- 4 acetal
- 1 19. The method of claim 16 where the diepoxide is acetaldehyde bis- (3,4-
- 2 epoxycyclohexylmethyl) acetal.
- 1 20. The method of claim 16 wherein the filler is non-electrically conductive.
- 1 21. The method of claim 16 wherein the filler is selected from the group consisting of
- 2 silver flake, aluminum nitride and silica-coated aluminum nitride.
- 1 22. The method of claim 16 wherein the filler is aluminum nitride or silica-coated
- 2 aluminum nitride.

- 1 23. The method of claim 16 wherein the adhesive further comprises a thixotropic
- 2 agent.
- 1 24. The method of claim 16 wherein the thixotropic agent comprises silica or
- 2 siloxane-coated formed silica.
- 1 25. The method of claim 24 wherein a) the amount of diepoxide is about 10 to about
- 2 30% by weight, b) the amount of cyclic anhydride is about 10 to about 30% by weight,
- 3 c) the amount of filler is about 40 to about 79% by weight and c) thixotropic agent is
- 4 about .05 to about 2% by weight, the amount being based upon the total of a), b), c)and d)
- 5 in the composition.
- 1 26. The method of claim 16 wherein the at least one semiconductor device is
- 2 electrically connected to the chip carrier with wirebonds after curing of the composition.
- 1 27. The method of claim 16 wherein the at least one semiconductor device is a flip
- 2 chip and wherein the flip chip is bonded to a heat spreader.
- 1 28. A reworkable thermally conductive adhesive composition comprising a) about 20
- 2 to about 60% by weight of a cured reaction product from diepoxide and a cyclic
- 3 anhydride wherein the epoxy groups are connected through an acyclic acetal moiety b)
- 4 about 40 to about 79% by weight of a thermally conductive filler; c) about 0.05 to about
- 5 2% by weight of a thixotropic agent based upon the total a), b), and c) in the composition.
- 1 29. The composition of claim 28 wherein the diepoxide is a cycloaliphatic diepoxide.

- 1 30. The composition of claim 28 wherein the diepoxide is selected from the group
- 2 consisting of acetaldehyde bis- (3,4 -epoxycyclophexyl) acetal, acetone bis- (3,4-
- 3 epoxycyclohexylmethyl) ketal, and formaldehyde bis- (3,4- epoxycyclohexylmethyl)
- 4 acetal.
- 1 31. The composition of claims 28 wherein the diepoxide is acetaldehyde bis- (3,4-
- 2 epoxycyclohexylmethyl) acetal.
- 1 32. The composition of claim 28 wherein the filler is non-electrically conductive.
- 1 33. The composition of claim 28 wherein the filler is selected from the group
- 2 consisting of silver flake, aluminum nitride and silica-coated aluminum nitride.
- 1 34. The composition of claim 28 wherein the filler is aluminum nitride or silicia-
- 2 coated aluminum nitride.
- 1 35. The composition of claim 28 wherein the thixotropic agent comprises silica or
- 2 siloxane-coated firmed silica.